

<b>Notice of References Cited</b>	Application/Control No. <b>09/754,829</b>	Applicant(s)/Patent Under Reexam <b>Mark J. Purdy et al.</b>	
	Examiner <b>Bret Chen</b>	Art Unit <b>1762</b>	Page 1 of 1

**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
A	5,298,311	3/1994	Bentson et al.	428	216
B	6,109,209	8/2000	Rudolph et al.	118	724
C	5,705,008	1/1998	Hecht	156	148
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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